

N-channel 100V 26.8 mΩ standard level MOSFET in D2PAK. Rev. 2 — 1 March 2012 Product data sh

Product data sheet

Product profile 1.

1.1 General description

Standard level N-channel MOSFET in D2PAK package qualified to 175C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

1.2 Features and benefits

- High efficiency due to low switching and conduction losses
- Suitable for standard level gate drive

1.3 Applications

- DC-to-DC converters
- Load switching

- Motor control
- Server power supplies

1.4 Quick reference data

Table 1.	Quick reference data					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	-	100	V
I _D	drain current	T_{mb} = 25 °C; V_{GS} = 10 V; see <u>Figure 1</u>	-	-	37	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	-	103	W
Tj	junction temperature		-55	-	175	°C
Static cha	aracteristics					
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 15 A; T _j = 100 °C; see <u>Figure 12</u>	-	-	48	mΩ
		V_{GS} = 10 V; I _D = 15 A; T _j = 25 °C; see <u>Figure 13</u>	-	21	26.8	mΩ
Dynamic	characteristics					
Q _{GD}	gate-drain charge	V_{GS} = 10 V; I_{D} = 30 A; V_{DS} = 50 V;	-	9	-	nC
Q _{G(tot)}	total gate charge	see Figure 14; see Figure 15	-	30	-	nC
Avalanch	e ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 37 A; $V_{sup} \le$ 100 V; unclamped; R_{GS} = 50 Ω	-	-	59	mJ



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2. Pinning information

Table 2.	Pinning	j information				
Pin	Symbol	Description	Simplified outline	Graphic symbol		
1	G	gate		_		
2	D	drain ^[1]	mb	B		
3	S	source				
mb	D	mounting base; connected to drain		mbb076 S		

SOT404 (D2PAK)

[1] It is not possible to make connection to pin 2

3. Ordering information

Table 3.Ordering information

Type number	Package		
	Name	Description	Version
PSMN027-100BS	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404

4. Limiting values

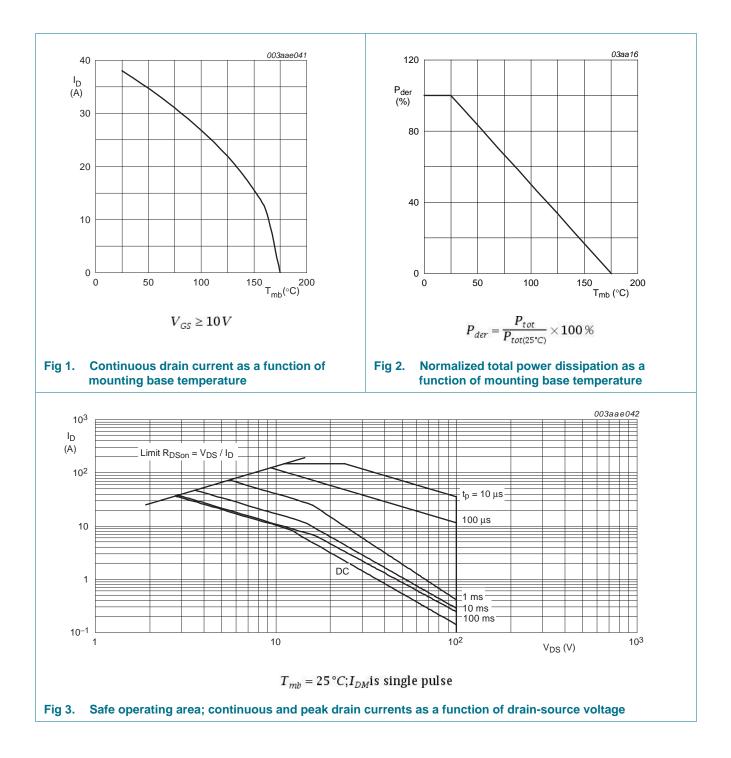
Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	100	V
V _{DGR}	drain-gate voltage	$T_j \le 175 \text{ °C}; T_j \ge 25 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$	-	100	V
V _{GS}	gate-source voltage		-20	20	V
I _D	drain current	V_{GS} = 10 V; T_{mb} = 100 °C; see <u>Figure 1</u>	-	26	А
		V_{GS} = 10 V; T_{mb} = 25 °C; see <u>Figure 1</u>	-	37	А
I _{DM}	peak drain current	pulsed; t _p ≤ 10 µs; T _{mb} = 25 °C; see <u>Figure 3</u>	-	148	A
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	103	W
T _{stg}	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
T _{sld(M)}	peak soldering temperature		-	260	°C
Source-dra	ain diode				
I _S	source current	T _{mb} = 25 °C	-	37	А
I _{SM}	peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^{\circ}C$	-	148	А
Avalanche	ruggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 37 A; $V_{sup} \le$ 100 V; unclamped; R_{GS} = 50 Ω	-	59	mJ

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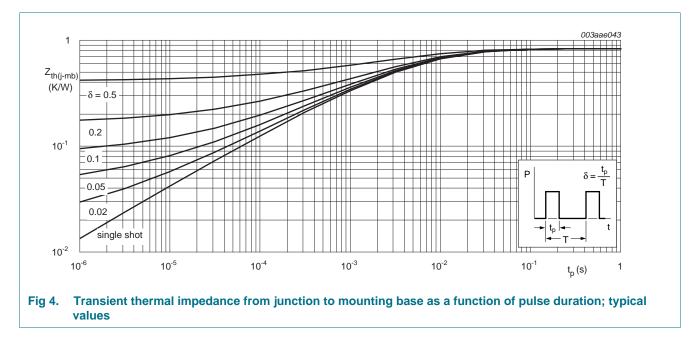
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5. Thermal characteristics

Table 5.	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	see Figure 4	-	0.8	1.46	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	Minimum footprint; mounted on a printed circuit board	-	60	-	K/W



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6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static char	racteristics					
V _{(BR)DSS}	drain-source breakdown	I _D = 0.25 mA; V _{GS} = 0 V; T _i = -55 °C	90	-	-	V
()	voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_i = 25 \text{ °C}$	100	-	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ see <u>Figure 10</u>	1	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see <u>Figure 11</u> ; see <u>Figure 10</u>	2	3	4	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ see <u>Figure 10</u>	-	-	4.8	V
I _{DSS}	drain leakage current	V_{DS} = 100 V; V_{GS} = 0 V; T_j = 125 °C	-	-	50	μA
		V _{DS} = 100 V; V _{GS} = 0 V; T _j = 25 °C	-	0.08	2	μA
I _{GSS}	gate leakage current	V _{GS} = 20 V; V _{DS} = 0 V; T _j = 25 °C	-	10	100	nA
		$V_{GS} = -20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nA
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 15 \text{ A}; T_j = 100 \text{ °C};$ see Figure 12	-	-	48	mΩ
		V _{GS} = 10 V; I _D = 15 A; T _j = 175 °C; see <u>Figure 12</u>	-	59	75	mΩ
		V _{GS} = 10 V; I _D = 15 A; T _j = 25 °C; see <u>Figure 13</u>	-	21	26.8	mΩ
R _G	internal gate resistance (AC)	f = 1 MHz	-	0.92	-	Ω
Dynamic c	haracteristics					
Q _{G(tot)}	total gate charge	$I_D = 30 \text{ A}; V_{DS} = 50 \text{ V}; V_{GS} = 10 \text{ V};$ see <u>Figure 14</u> ; see <u>Figure 15</u>	-	30	-	nC
		$I_D = 0 \text{ A}; V_{DS} = 0 \text{ V}; V_{GS} = 10 \text{ V}$	-	24	-	nC
Q _{GS}	gate-source charge	$I_D = 30 \text{ A}; V_{DS} = 50 \text{ V}; V_{GS} = 10 \text{ V};$ see Figure 14; see Figure 15	-	8	-	nC
Q _{GS(th)}	pre-threshold gate-source charge	I_D = 30 A; V_{DS} = 50 V; V_{GS} = 10 V; see <u>Figure 14</u>	-	4.8	-	nC
Q _{GS(th-pl)}	post-threshold gate-source charge		-	3.4	-	nC
Q _{GD}	gate-drain charge	$I_D = 30 \text{ A}; V_{DS} = 50 \text{ V}; V_{GS} = 10 \text{ V};$ see <u>Figure 14</u> ; see <u>Figure 15</u>	-	9	-	nC
V _{GS(pl)}	gate-source plateau voltage	V _{DS} = 50 V; see <u>Figure 14</u> ; see <u>Figure 15</u>	-	4.9	-	V
C _{iss}	input capacitance	$V_{DS} = 50 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$	-	1624	-	pF
C _{oss}	output capacitance	$T_j = 25 \text{ °C}; \text{ see } Figure 16$	-	115	-	pF
C _{rss}	reverse transfer capacitance		-	74	-	pF
d(on)	turn-on delay time	$V_{DS} = 50 \text{ V}; \text{ R}_{L} = 1.7 \Omega; V_{GS} = 10 \text{ V}; \label{eq:VDS}$	-	14.4	-	ns
r	rise time	$R_{G(ext)} = 4.7 \ \Omega; \ T_{j} = 25 \ ^{\circ}C$	-	11.4	-	ns
d(off)	turn-off delay time		-	29.6	-	ns
t _f	fall time		-	8.9	-	ns

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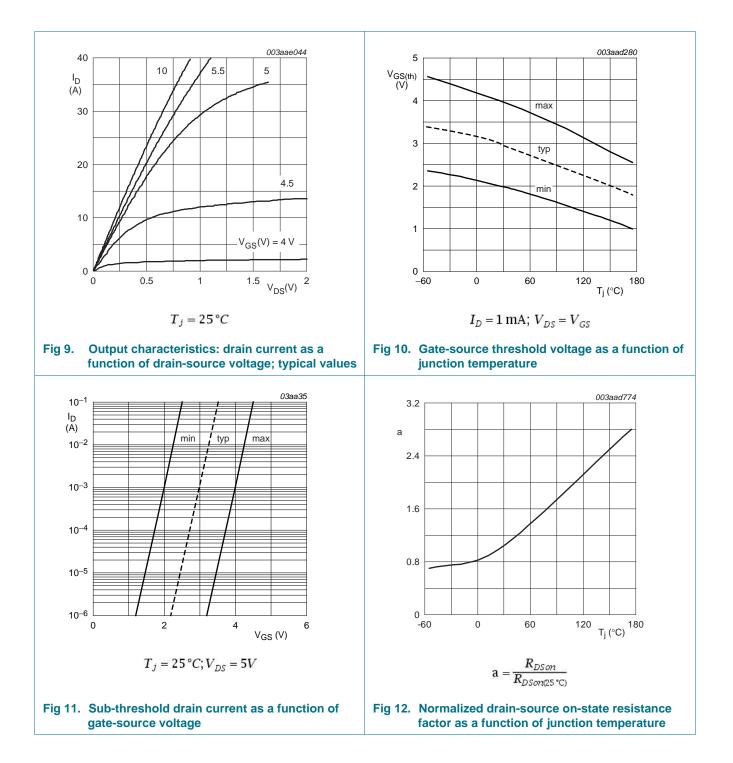
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Symbol	Parameter	Conditions	Min Typ Max Uni
	ain diode		
SD	source-drain voltage	$I_S = 15 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C};$ see <u>Figure 17</u>	- 0.8 1.2 V
r	reverse recovery time	$I_{S} = 10 \text{ A}; \text{ dI}_{S}/\text{dt} = 100 \text{ A}/\mu\text{s}; \text{ V}_{GS} = 0$	V; - 47 - ns
Q _r	recovered charge	$V_{DS} = 50 V$	- 91 - nC
60 9 _{fs} (S) 45		003aae046 40 1 _D (A) 30	003aae045
30		20	
15		10	$T_j = 175 \circ C$ $T_j = 25 \circ C$
0 I C	0 10 20 30	0 0 0 0	2 4 V _{GS} (V) 6
	$T_j = 25 ^{\circ}C; V_{DS} = 10 ^{\circ}V_{DS}$	¢.	$V_{DS} > I_D \times R_{DSon}$
-	orward transconductance as rain current; typical values		characteristics: drain current as a of gate-source voltage; typical value
0000		003aae047 4.20	003aae049
3000 C		Ciss 120 R _{DSon} (mΩ)	
(pF)		90	
2000		C _{rss} 60	
1000			
		30	
0	D 5 V _{GS}	0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	5 10 15 _{VGS} (V) 20
			$T_j = 25 ^{\circ}C; I_D = 10A$
	$V_{DS} = 0V; f = 1MHz$		$I_j = 25$ C, $I_D = 10A$

Table 6. Characteristics ...continued

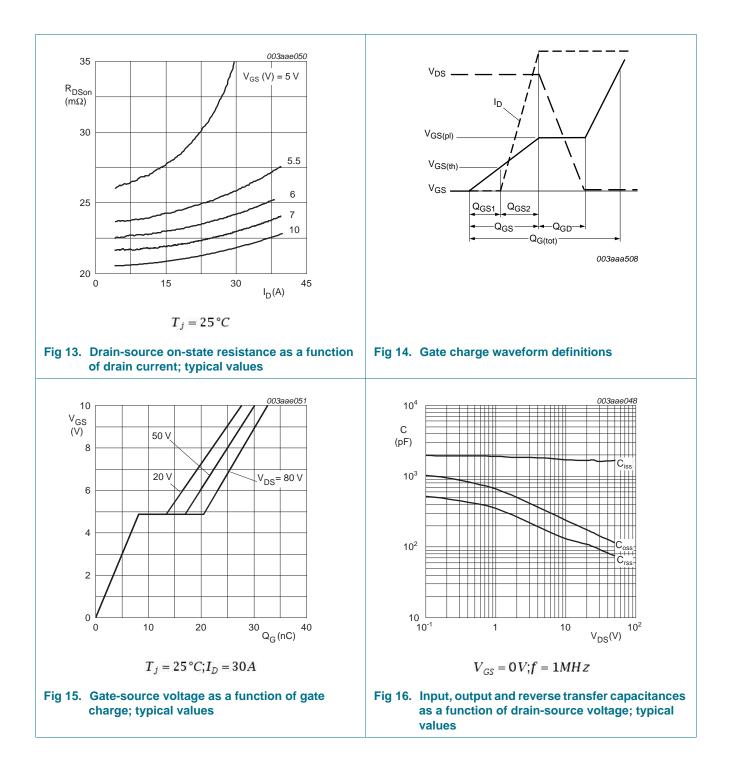
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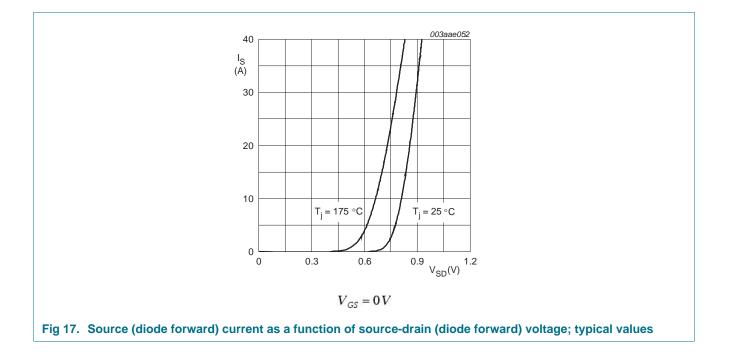
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7. Package outline

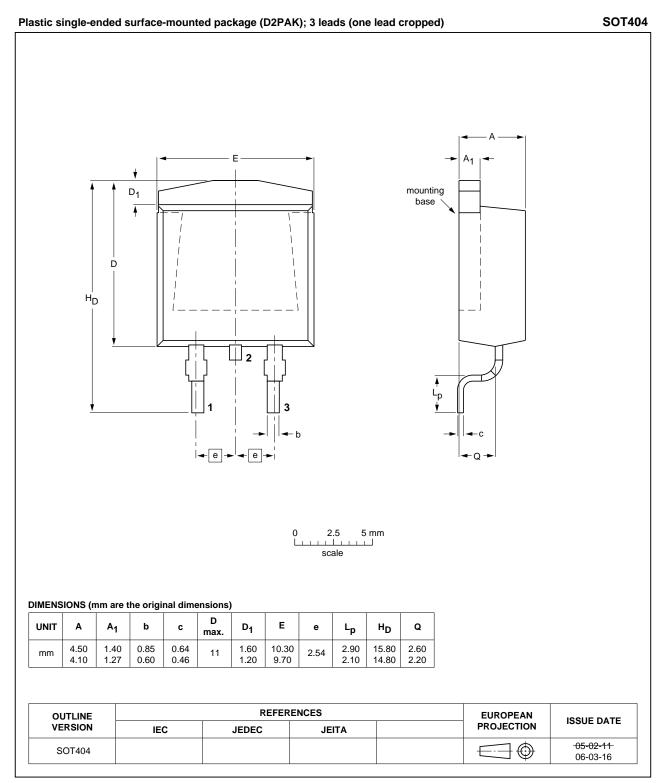


Fig 18. Package outline SOT404 (D2PAK)

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8. Revision history

Table 7. Revision h	istory			
Document ID	Release date	Data sheet status	Change notice	Supersedes
PSMN027-100BS v.2	20120301	Product data sheet	-	PSMN027-100BS v.1
Modifications:	 Status change 	ed from objective to product.		
	 Various chang 	ges to content.		
PSMN027-100BS v.1	20111020	Objective data sheet	-	-

Legal information 9.

9.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

Please consult the most recently issued document before initiating or completing a design. [1]

[2] The term 'short data sheet' is explained in section "Definitions"

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